

#2 2188  
4-18-01  
PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of  
William A. CHREN, Jr.

Serial No. 09/656,550

Filed: September 6, 2000

For: RESIDUE NUMBER SYSTEM ARITHMETIC CIRCUITS WITH BUILT-IN SELF TEST

: Atty. Docket: 00-LM-007

: Group Art Unit: 2787

RECEIVED  
FEB - 7 2001  
Technology Center 2100INFORMATION DISCLOSURE STATEMENTAssistant Commissioner for Patents  
Washington, D. C. 20231

SIR:

The attached Form PTO-1449 provides a listing of information which may be relevant to the subject application. This IDS is not intended as a representation that better art is not available, nor that the information provided is prior art.

This IDS is submitted under:

- ☒ 37 CFR 1.97(b) - No Fee.  
☐ 37 CFR 1.97(c) - No Fee, with Certification.  
☐ 37 CFR 1.97(c) - Fee.  
☐ 37 CFR 1.97(d) - Fee, Certification & Petition.

The Commissioner is authorized to charge any required fees under 37 CFR 1.17(p) and (i) (1) to Deposit Account No. 50-1556.

Respectfully submitted,

Date:

1/31/01

By:

  
Stephen Bongini  
Registration No. 40,917

FLEIT, KAIN, GIBBONS,  
GUTMAN & BONGINI P.L.  
One Boca Commerce Center  
551 Northwest 77th Street, Suite 111  
Boca Raton, Florida 33487  
(561) 989-9811  
(561) 989-9812 (facsimile)

**CERTIFICATE OF MAILING**

I hereby certify that this correspondence is being deposited with the United States Postal Service by first class mail in an envelope addressed to: Assistant Commissioner for Patents, Washington, DC 20231

Ellen H. Ullman

Name of Person Mailing Paper

Ellen H. Ullman

Signature of Person Mailing Paper

2/1/01

Date of Deposit